

MOSFET - N-Channel, QFET

200 V, 5.5 A, 750 mΩ

FQD7N20L

Description

This N-Channel Enhancement Mode Power MOSFET is produced using **onsemi**'s proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, active power factor correction (PFC), and electronic lamp ballasts.

Features

- 5.5 A, 200 V $R_{DS(on)} = 750 \text{ m}\Omega$ (Max.) @ $V_{GS} = 10 \text{ V}$, $I_D = 2.75 \text{ A}$
- Low Gate Charge (Typ. 6.8 nC)
- Low C_{rss} (Typ. 8.5 pF)
- 100% Avalanche Tested
- Low Level Gate Drive Requirement Allowing Direct Operating from Logic Drivers.
- This Device is Pb-Free Halide, Free and RoHS Compliant.

ABSOLUTE MAXIMUM RATINGS

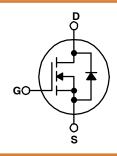
(T_C = 25°C unless otherwise noted.)

Symbol	Parameter	Value	Unit
V _{DSS}	Drain-Source Voltage	200	V
I _D	Drain Current - Continuous (T _C = 25°C) - Continuous (T _C = 100°C)	5.5 3.48	Α
I _{DM}	Drain Current - Pulsed (Note 1)	22	Α
V_{GSS}	Gate-Source Voltage	±20	V
E _{AS}	Single Pulsed Avalanche Energy (Note 2) 73		mJ
I _{AR}	Avalanche Current (Note 1)	5.5	Α
E _{AR}	Repetitive Avalanche Energy (Note 1)	4.5	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)	5.5	V/ns
P _D	Power Dissipation (T _A = 25°C) *	2.5	W
	Power Dissipation – (T _C = 25°C) – Derate Above 25°C	45 0.36	W W/°C
T _J ,T _{STG}	Operating and Storage Temperature Range	-55 to +150	°C
TL	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds	300	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



DPAK3 CASE 369AS



MARKING DIAGRAM

&Z&3&K FQD 7N20L

&Z = Assembly Plant Code &3 = Date Code (Year & week) &K = 2-Digit Lot Code FQD7N20L = Specific Device Code

ORDERING INFORMATION

Device	Package	Shipping [†]	
FQD7N20LTM	DPAK3	2500 /	
	(Pb-Free)	Tape & Reel	

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

THERMAL CHARACTERISTICS

Symbol	Parameter	Value	Unit
$R_{ heta JC}$	Thermal Resistance, Junction to Case, Max	2.78	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Minimum Pad of 2–oz Copper), Max.	110	
	Thermal Resistance, Junction to Ambient (*1 in² Pad of 2-oz Copper), Max.	50	°C/W

ELECTRICAL CHARACTERISTICS ($T_C = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
Off Charac	cteristics	•		_		
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} = 0 V, I _D = 250 μA	200	_	-	V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, Referenced to 25°C	-	0.17	-	V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 200 V, V _{GS} = 0 V	-	-	1	μΑ
		V _{DS} = 160 V, T _C = 125°C	-	-	10	μΑ
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 20 V, V _{DS} = 0 V	-	-	100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = -20 V, V _{DS} = 0 V	-	-	-100	nA
On Charac	cteristics	•				
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1.0	_	2.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10 V, I _D = 2.75 A V _{GS} = 5 V, I _D = 2.75 A	-	0.59 0.62	0.75 0.78	Ω
9 _{FS}	Forward Transconductance	$V_{DS} = 30 \text{ V}, I_D = 2.75 \text{ A}$	-	5.6	-	S
Dynamic (Characteristics					
C _{iss}	Input Capacitance	V _{DS} = 25 V, V _{GS} = 0 V, f = 1.0 MHz	-	390	500	pF
C _{oss}	Output Capacitance		-	55	70	pF
C _{rss}	Reverse Transfer Capacitance		-	8.5	11	pF
Switching	Characteristics					
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 100 \text{ V}, I_D = 6.5 \text{ A},$	-	12	35	ns
t _r	Turn-On Rise Time	$R_G = 25 \Omega \text{ (Note 4)}$	-	125	260	ns
t _{d(off)}	Turn-Off Delay Time		-	20	50	ns
t _f	Turn-Off Fall Time		-	65	140	ns
Qg	Total Gate Charge	$V_{DS} = 160 \text{ V}, I_D = 6.5 \text{ A},$	-	6.8	9.0	nC
Q _{gs}	Gate-Source Charge	V _{GS} = 5 V (Note 4)	-	1.6	-	nC
Q _{gd}	Gate-Drain Charge		-	3.4	-	nC
Drain-Sou	urce Diode Characteristics and Maximum	Ratings				
IS	Maximum Continuous Drain-Source Diode Forward Current		-	-	5.5	Α
I _{SM}	Maximum Pulsed Drain-Source Diode Fo	Maximum Pulsed Drain-Source Diode Forward Current		-	22	Α
V _{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 5.5 A	-	_	1.5	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0 V, I _S = 6.5 A,	-	110	-	ns
Q _{rr}	Reverse Recovery Charge	dl _F /dt = 100 A/μs	-	0.44	-	μC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

NOTES:

- 1. Repetitive Rating: Pulse–width limited by maximum junction temperature.
 2. L = 3.6 mH, I_{AS} = 5.5 A, V_{DD} = 50 V, R_{G} = 25, Ω starting T_{J} = 25°C.
 3. $I_{SD} \le 6.5$ A, di/dt ≤ 300 A/ μ s, $V_{DD} \le BV_{DSS}$, starting T_{J} = 25°C.
 4. Essentially independent of operating temperature.

TYPICAL CHARACTERISTICS

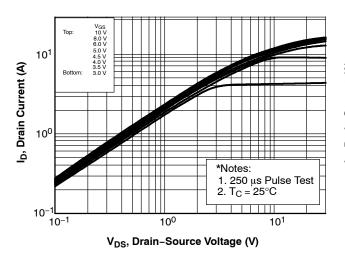


Figure 1. On-Region Characteristics

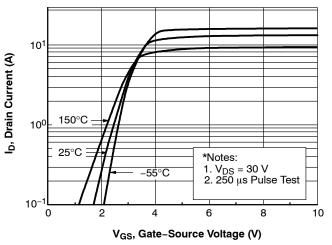


Figure 2. Transfer Characteristics

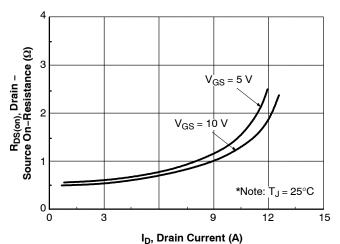


Figure 3. On–Resistance Variation vs
Drain Current and Gate Voltage

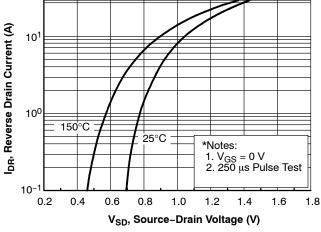


Figure 4. Body Diode Forward Voltage Variation vs Source Current and Temperature

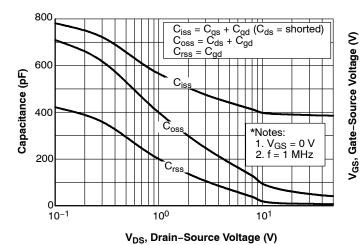


Figure 5. Capacitance Characteristics

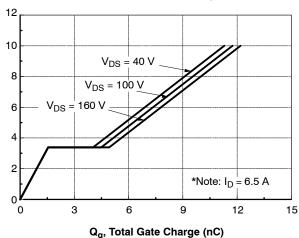


Figure 6. Gate Charge Characteristics

TYPICAL CHARACTERISTICS (CONTINUED)

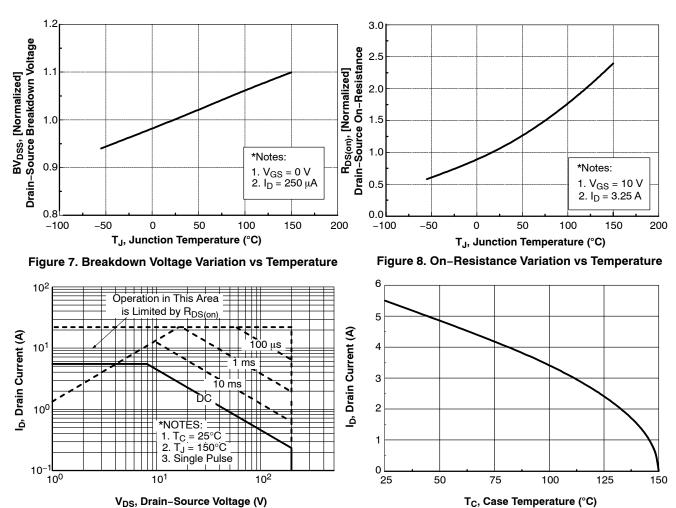


Figure 9. Maximum Safe Operating Area

Figure 10. Maximum Drain Current vs. Case Temperature

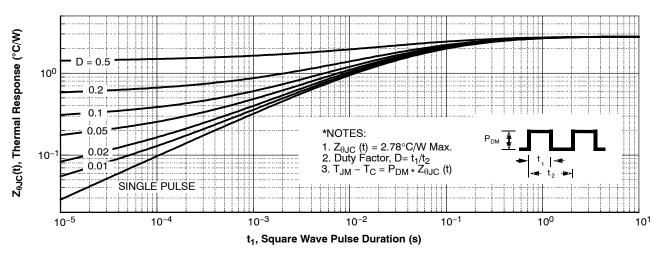


Figure 11. Transient Thermal Response Curve

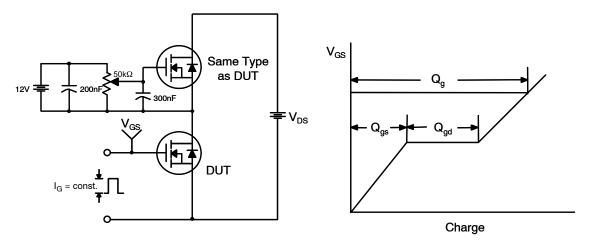


Figure 12. Gate Charge Test Circuit & Waveform

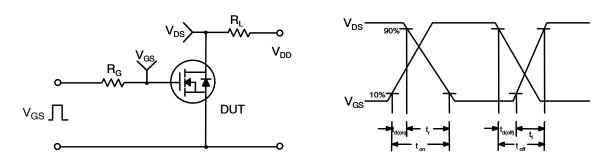


Figure 13. Resistive Switching Test Circuit & Waveforms

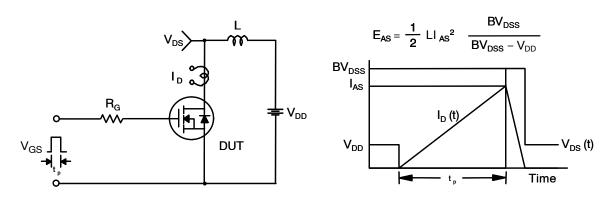
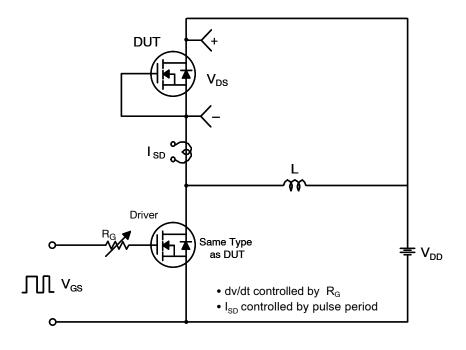


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms



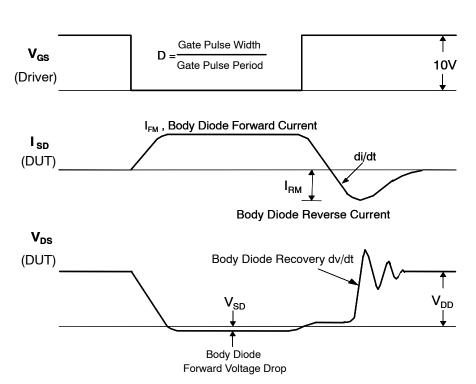


Figure 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms





DPAK3 6.10x6.54x2.29, 4.57P CASE 369AS **ISSUE B**

DATE 20 DEC 2023

- NOTES: UNLESS OTHERWISE SPECIFIED

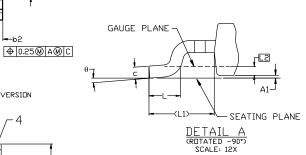
 A) THIS PACKAGE CONFORMS TO JEDEC, TO-252, ISSUE F, VARIATION AA.

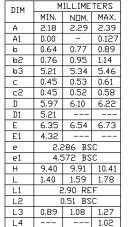
 B) ALL DIMENSIONS ARE IN MILLIMETERS.

 C) DIMENSIONING AND TOLERANCING PER

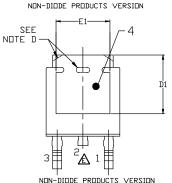
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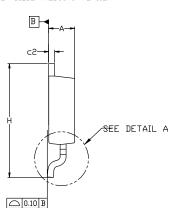
- A
- F)
- DIMENSIONING AND TOLERANCING PER
 ASME Y14.5M-2018.
 SUPPLIER DEPENDENT MOLD LOCKING HOLES OR CHAMFERED
 CORNERS OR EDGE PROTRUSION.
 FOR DIGDE PRODUCTS, L4 IS 0.25 MM MAX PLASTIC BODY
 STUB WITHOUT CENTER LEAD.
 DIMENSIONS ARE EXCLUSIVE OF BURRS,
 MOLD FLASH AND TIE BAR EXTRUSIONS.
 LAND PATTERN RECOMMENDATION IS BASED ON IPC7351A STD
 T0228P991X239-3N.





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A

5.55	MIN-
	6.50 MIN
6.40 LXXX	
1	2.85 MIN
	1.25 MIN
4.5	2.286

LAND PATTERN RECOMMENDATION

*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

GENERIC MARKING DIAGRAM*

10°

XXXXXX XXXXXX **AYWWZZ**

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

XXXX = Specific Device Code

= Assembly Location Α

Υ = Year

WW = Work Week

77 = Assembly Lot Code

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